

<b>Notice of References Cited</b>	Application/Control No. 10/750,378		Applicant(s)/Patent Under Reexamination KOL ET AL.	
	Examiner Van Kim T. Nguyen		Art Unit 2456	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,020,697	03-2006	Goodman et al.	709/223
*	B	US-2003/0236693	12-2003	Chen et al.	705/9
*	C	US-2002/0108099	08-2002	Paclat, Charles	717/102
*	D	US-2002/0065701	05-2002	Kim et al.	705/9
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.